



SURFACE MOUNT GENERAL PURPOSE RECTIFIERS

S1AAF ~ S1MAF



SMAF

SMAF SURFACE MOUNT PLASTIC PACKAGE RoHS compliant

FEATURE:

- 1. Glass Passivated Junction Chip
- 2. The Plastic Package has Underwriters Laboratory Flammability Classification 94V-0.
- 3. Low Reverse Leakage
- 4. Built-in Strain Relief, Ideal for Automated Placement
- 5. High Forward Surge Current Capability
- 6. High Temperature Soldering : 260°C / 10 seconds at Terminals.
- 7. Colour Band denotes the Cathode end
- 8. Terminals Solder Plated, Solderable as per MIL-STD-750, Method 2026
- 9. Weight : 0.038 grams
- 10. This product is available in AEC-Q101 Compliant and PPAP Capable also.

Note: For AEC-Q101 compliant products, please use suffix -AQ in the part number while ordering.

ABSOLUTE MAXIMUM RATINGS (Ta = 25 °C Unless otherwise specified)

PARAMETER	SYMBOL	S1A	S1B	S1D			S1K		UNIT
		AF	AF	AF	AF	AF	AF	AF	
Maximum Repetitive Peak Reverse Voltage	V_{RRM}	50	100	200	400	600	800	1000	V
Maximum RMS Voltage	V _{RMS}	35	70	140	280	420	560	700	V
Maximum DC Blocking Voltage	V _{DC}	50	100	200	400	600	800	1000	V
Maximum Average Forward Rectified					10				Λ
Current at T _L =110⁰C	F(AV)	I _{F(AV)} 1.0			A				
Peak Forward Surge Current									
8.3ms Single Half Sine-Wave Superimposed	I _{FSM} 30			А					
on RatedLoad									
Maximum Instantaneous Forward Voltage at	V	1.1					V		
I _F =1A	V _F	1.1							
Maximum DC Reverse Current	1	5.0		μA					
@ Rated DCBlocking Voltage	I _R	50		μA					
Typical Junction Capacitance ¹	CJ	15		pF					
Typical Thermal Resistance ²	R _{th (J-A)}	75		°C/W					
Operating Junction and Storage	T _J , T _{STG} -55 to +150			°C					
Temperature Range	-55 to +150			U U					

Note:

1. Measured at 1MHz and Applied Reverse Voltage of 4.0V D.C.

2. P.C.B. mounted with 0.2 X 0.2" (5.0 X 5.0mm) Copper Pad Area

S1AAF_S1MAF Rev01_20082022E



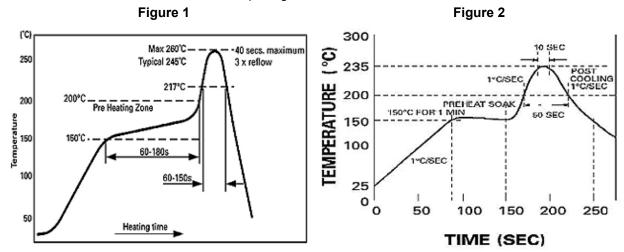


Recommended Reflow Solder Profiles

The recommended reflow solder profiles for Pb and Pb-free devices are shown below.

Figure 1 shows the recommended solder profile for devices that have Pb-free terminal plating, and where a Pb-free solder is used.

Figure 2 shows the recommended solder profile for devices with Pb-free terminal plating used with leaded solder, or for devices with leaded terminal plating used with a leaded solder.



Reflow profiles in tabular form				
Profile Feature	Pb-Free System			
Average Ramp-Up Rate	~3°C/second	~3°C/second		
Preheat – Temperature Range – Time	150-170°C 60-180 seconds	150-200°C 60-180 seconds		
Time maintained above: – Temperature – Time	200°C 30-50 seconds	217°C 60-150 seconds		
Peak Temperature	235°C	260°C max.		
Time within +0 -5°C of actual Peak	10 seconds	40 seconds		
Ramp-Down Rate	3°C/second max.	6°C/second max.		

S1AAF_S1MAF Rev01_20082022E

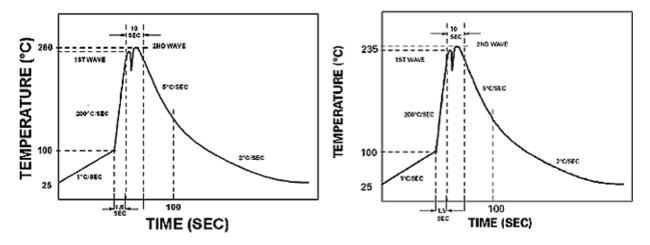
Continental Device India Pvt. Limited





Recommended Wave Solder Profiles

The Recommended solder Profile For Devices with Pb-free terminal plating where a Pb-free solder is used The Recommended solder Profile For Devices with Pb-free terminal plating used with leaded solder, or for devices with leaded terminal plating used with leaded solder



Wave Profiles in Tabular Form

Profile Feature	Sn-Pb System	Pb-free System
Average Ramp-Up Rate	~200°C/second	~200°C/second
Heating rate during preheat	Typical 1-2, Max 4°C/sec	Typical 1-2, Max 4°C/Sec
Final preheat Temperature	Within 125°C of Solder Temp	Within 125°C of Solder Temp
Peak Temperature	235°C	260°C max.
Time within +0 -5°C of actual Peak	10 seconds	10 seconds
Ramp-Down Rate	5°C/second max.	5°C/second max.





TYPICAL CHARACTERISTIC CURVES

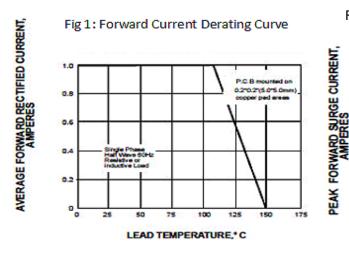


Fig 4: Maximum Non-Repetitive Peak Forward Surge Current

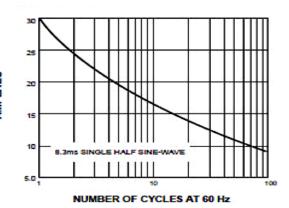
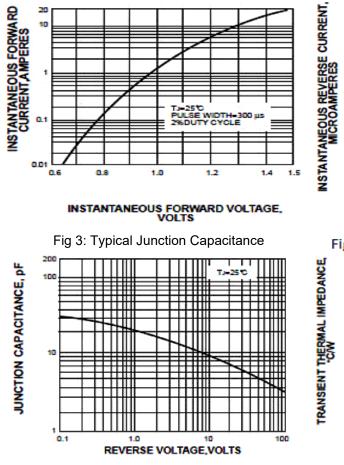
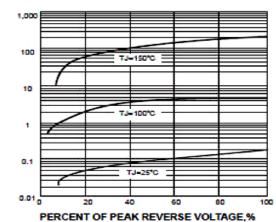


Fig 2: Typical Instantaneous Forward Charateristics

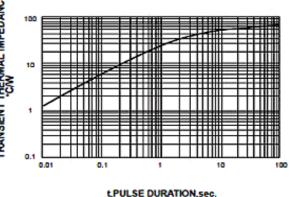


S1AAF_S1MAF Rev01_20082022E

Fig 5: Typical Reverse Charateristics



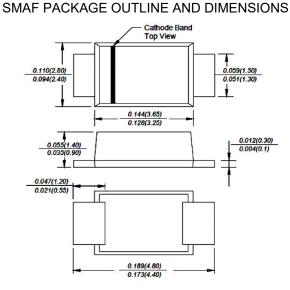






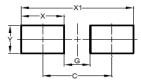


PACKAGE DETAILS



Dimensions in inches and (millimeters)

Suggested Pad layout



Dimensions	Value (in mm)	
С	4.00	
G	1.50	
Х	2.50	
X1	6.50	
Y	1.70	

S1AAF_S1MAF Rev01_20082022E

Continental Device India Pvt. Limited





<u>Recommended Product Storage Environment for Discrete</u> <u>Semiconductor Devices</u>

This storage environment assumes that the Diodes and transistors are packed properly inside the original packing supplied by CDIL.

- · Temperature 5 °C to 30 °C
- · Humidity between 40 to 70 %RH
- · Air should be clean.
- · Avoid harmful gas or dust.
- \cdot Avoid outdoor exposure or storage in areas subject to rain or water spraying .
- Avoid storage in areas subject to corrosive gas or dust. Product shall not be stored in areas exposed to direct sunlight.
- · Avoid rapid change of temperature.
- · Avoid condensation.
- · Mechanical stress such as vibration and impact shall be avoided.
- · The product shall not be placed directly on the floor.
- The product shall be stored on a plane area. They should not be turned upside down. They should not be placed against the wall.

Shelf Life of CDIL Products

The shelf life of products is the period from product manufacture to shipment to customers. The product can be unconditionally shipped within this period. The period is defined as 2 years.

If products are stored longer than the shelf life of 2 years the products shall be subjected to quality check as per CDIL quality procedure.

The products are further warranted for another one year after the date of shipment subject to the above conditions in CDIL original packing.

Floor Life of CDIL Products and MSL Level

When the products are opened from the original packing, the floor life will start. For this, the following JEDEC table may be referred:

JEDEC MSL Level				
Level	Time	Condition		
1	Unlimited	≤30 °C / 85% RH		
2	1 Year	≤30 °C / 60% RH		
2a	4 Weeks	≤30 °C / 60% RH		
3	168 Hours	≤30 °C / 60% RH		
4	72 Hours	≤30 °C / 60% RH		
5	48 Hours	≤30 °C / 60% RH		
5a	24 Hours	≤30 °C / 60% RH		
6	Time on Label(TOL)	≤30 °C / 60% RH		

S1AAF_S1MAF Rev01_20082022E





Customer Notes

Component Disposal Instructions

- 1. CDIL Semiconductor Devices are RoHS compliant, customers are requested to please dispose as per prevailing Environmental Legislation of their Country.
- 2. In Europe, please dispose as per EU Directive 2002/96/EC on Waste Electrical and Electronic Equipment (WEEE).

Disclaimer

The product information and the selection guides facilitate selection of the CDIL's Semiconductor Device(s) best suited for application in your product(s) as per your requirement. It is recommended that you completely review our Data Sheet(s) so as to confirm that the Device(s) meet functionality parameters for your application. The information furnished in the Data Sheet and on the CDIL Web Site/CD are believed to be accurate and reliable. CDIL however, does not assume responsibility for inaccuracies or incomplete information. Furthermore, CDIL does not assume liability whatsoever, arising out of the application or use of any CDIL product; neither does it convey any license under its patent rights nor rights of others. These products are not designed for use in life saving/support appliances or systems. CDIL customers selling these products (either as individual Semiconductor Devices or incorporated in their end products), in any life saving/support appliances or systems or applications do so at their own risk and CDIL will not be responsible for any damages resulting from such sale(s).

CDIL strives for continuous improvement and reserves the right to change the specifications of its products without prior notice.



CDIL is a registered trademark of **Continental Device India Pvt. Limited** C-120 Naraina Industrial Area, New Delhi 110 028, India. Telephone +91-11-2579 6150, 4141 1112 Fax +91-11-2579 5290, 4141 1119 email@cdil.com www.cdil.com CIN No. U32109DL1964PTC004291

S1AAF_S1MAF Rev01_20082022E

Continental Device India Pvt. Limited